

Using Microfluidic Chips with Nanochannels for Measuring the Mean Inner Potential of Liquid Water by Off-Axis Electron Holography

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Electrons interact with the electric and magnetic fields existing within and around a TEM specimen which leads to changes in the transmitted electron wave function. Electron holography [1] can be used to measure the phase and amplitude changes of the electron wave. Off-axis electron holography [2] requires a coherent and bright beam split into two parts: one passes through sample as object wave; one pass through vacuum as reference wave. A charged biprism wire tilts the reference wave relative to the object wave, so that the two waves interfere and a hologram TEM image can be recorded.

The mean inner potential (MIP) V_0 is a volume-averaged electrostatic potential of a material [3, 4]. It is a fundamental property of the material, and depends on both composition and structure. It is useful for e.g. studies of the work function, iconicity of the solid, band structure in van der Waals bonded crystals. Electron holography is potentially the most accurate method to measure MIP, and considerable efforts have been focused on determining the MIP for solid materials mostly with known geometries [5].

However, very little has been made on liquid phase materials with MIP measurement until now. This is due to the limitation by several factors: Firstly, water based solutions have high vapor pressures making them technically difficult to introduce into the high vacuum in a TEM, and they are susceptible to charging and beam damage under electron beams. Secondly, electron holographic MIP measurement requires accurate geometry and thickness measurements [6], which can be difficult to achieve on liquid samples. So far, work has only been done on vitrified ice [7]. Ionic liquid (IL) has also been studied, but found that electron irradiation changed the electrostatic potential around the IL, and specific MIP value was not obtained [8].

The change in phase $\Delta\phi$ of an electron wave passing through a material relative to the phase of an electron wave passing through vacuum, is proportional to both thickness t and the MIP V_0 , as written equation below [9]:

$$\Delta\phi = \frac{2\pi}{\lambda} \frac{E_0 + E}{2E_0 + E} V_0 t = C_E V_0 t$$

Where λ is the electron wavelength, e is the electron charge, E is the electron kinetic energy, and E_0 is the electron rest energy. The first term can be simplified as C_E , a constant depending only on the electron beam energy that equals 6.53×10^6 rad/Vm at $E = 300$ keV. Hence, if both the phase change $\Delta\phi$ relative to the vacuum and the thickness t are known in a liquid sample, the MIP of that sample can be calculated straightforwardly.

Here, we take advantage of the recent development of in-situ liquid TEM microchip systems used to observe processes in aqueous or other liquid samples [10] and use a newly developed system to measure the MIP of liquid water solution of 1mM NaCl. Multiple suspended Si_3N_4 nanochannels for TEM were created by bonding two silicon microchips. More details about the chip fabrication were reported in our previous work [11]. As illustrated in Figure 1A, the liquid solution is confined in an electron transparent Si_3N_4 nanochannel, which is supported by two bonding Si_3N_4 membranes. The nanochannel height, namely the liquid thickness was determined already from both the fabrication process and EELS measurements to be 100 ± 3 nm. The phase image in Figure 1B was reconstructed from the original hologram images. A phase change of 2.1 ± 0.4 rad was found from the liquid sample and suspended Si_3N_4 membranes relative to the enclosing Si_3N_4 membranes. Therefore, using the equation above, the MIP V_0 of water solution is calculated to be 3.2 ± 0.36 V which within error matches the published value of 3.5 ± 1.2 V measured on vitrified ice [12].

References:

- [1] D Gabor, Nature **161** (1948), p. 777.
- [2] G Mollenstedt and H Duker, Zeitschrift Fur Physik **145** (1956), p. 377.
- [3] H Bethe, Annalen der Physik **87** (1928), p. 55.
- [4] A Sanchez and MA Ochando, Journal of Physics C-Solid State Physics **18** (1985), p. 33.
- [5] T Tanigaki *et al*, Journal of Physics D-Applied Physics **49** (2016).
- [6] M Gajdardziskajosifovska *et al*, Ultramicroscopy **50** (1993), p. 285.
- [7] A Harsher and H Lichte, Electron Microscopy **1** (1998), p. 553.
- [8] M Shirai *et al*, Ultramicroscopy **146** (2014), p. 125.
- [9] LFA Edgar Völkl and CJ David in “Introduction to Electron Holography”, (Springer US) p. 354.
- [10] FM Ross, Science **350** (2015).
- [11] S Lagana *et al*, European Microscopy Congress (EMC) 2016, DOI: 10.1002/emc2016.0319.
- [12] We would like to thank DTU Nanotech, DTU CEN, DTU Danchip, and the funding from the Danish Research Council for Technology and Production Case No. 12-126194.

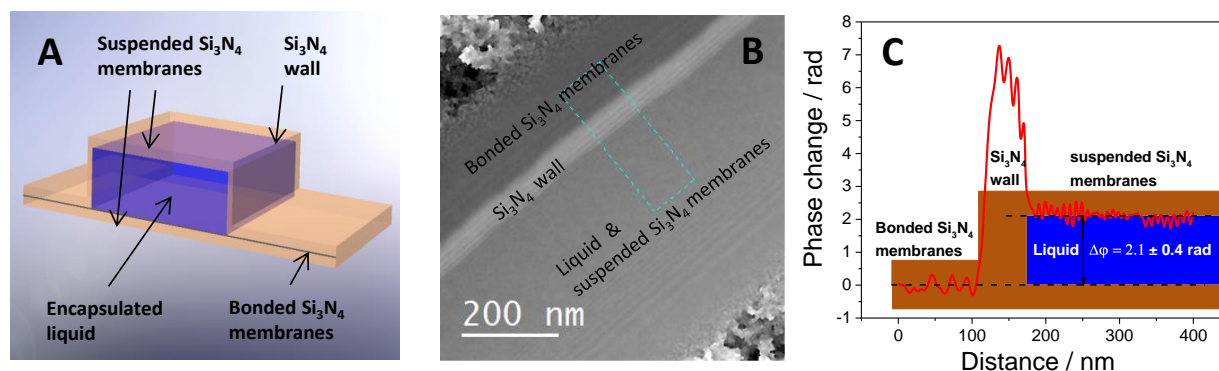


Figure 1. A). A schematic illustration of a single nanochannel filled with liquid sample of 1mM NaCl water solution; B). Reconstructed phase image from original hologram images; C). A phase profile from Figure 1B obtained by averaging the phase image over 110 nm parallel to the Si_3N_4 wall.